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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

RF-97

Applicant(s) : Heiko Zota
Serial No. : 10/815,268
Filed : March 31, 2004
For : MEASURING APPARATUS FOR DETERMINING THE THICKNESS
OF PAPER SHEETS OR SIMILAR FLAT PRODUCTS

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

S I R:

The attention of the Examiner and of the Patent and Trademark Office is hereby directed to the references listed on attached form PTO-1449. The references were cited in the European Search Report, a copy of which is enclosed. Copies of the references are forwarded herewith.

With the submission of this admitted prior art, applicant thus complies with the duty of disclosure as set forth at 37 CFR 1.56.

Respectfully submitted,

FK:ml

Dated: August 6, 2004

By

Friedrich Kueffner

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Encls: **Four {4} References**

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on August 6, 2004.

August 6, 2004

Friedrich Kueffner

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Form PTO-1449		Docket No.: RF-97		Serial No.: 10/815,268			
LIST OF PRIOR ART CITED BY APPLICANT		Applicant: Heiko Zota					
		Filing Date: March 31, 2004		Group:			
U.S. PATENT DOCUMENTS							
Exam. Init.	Document Number	Date	NAME	Class	Filing Date if appropriate		
AA							
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AD							
AE							
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AH							
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	COUNTRY	Class	Subclass	TRANSLATION	
						Yes	No
AK	0 0 9 6 7 4 2	12/83	EUROPEAN				X
AL	2 1 5 3 5 3 3	8/85	UNITED KINGDOM				
AM	0 5 4 8 8 7 4	6/93	EUROPEAN				X
AN							
OTHER PRIOR ART (including Author, Title, Date, Pertinent Pages, Etc.)							
AP	PATENT ABSTRACTS OF JAPAN, VOL. 013, NO. 245 (P-881), JUNE 8, 1989 &						
	JP 01 047902 A (FUJITSU LTD), FEBRUARY 22, 1989						
AQ							
AR							
EXAMINER				DATE CONSIDERED			

